

# SILICON TRANSISTOR 2SC2351

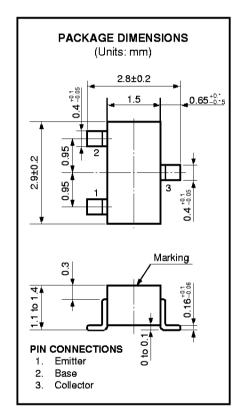
# HIGH FREQUENCY LOW NOISE AMPLIFIER NPN SILICON EPITAXIAL TRANSISTOR MINI MOLD

### **FEATURES**

NF 1.5 dB TYP. @ f = 1.0 GHz
 MAG 14 dB TYP. @ f = 1.0 GHz

# ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

Collector to Base Voltage	VcBo	25	V
Collector to Emitter Voltage	VCEO	12	V
Emitter to Base Voltage	$V_{EBO}$	3.0	V
Collector Current	lc	70	mΑ
Total Power Dissipation	Рт	250	mW
Junction Temperature	$T_j$	150	°C
Storage Temperature	Tstg	-65 to +150	°C



# ELECTRICAL CHARACTERISTICS (TA = 25 °C)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Collector Cutoff Current	Ісво			0.1	μΑ	VcB = 15 V, IE = 0
Emitter Cutoff Current	Ієво			0.1	μΑ	VEB = 2.0 V, Ic = 0
DC Current Gain	h⊧∈	40		200		Vc= = 10 V, lc = 20 mA
Gain Bandwidth Product	f⊤		4.5		GHz	Vc= = 10 V, lc = 20 mA
Output Capacitance	Cob		0.75	1.0	pF	VcB = 10 V, IE = 0, f = 1.0 MHz
Insertion Power Gain	S <sub>21</sub> e  <sup>2</sup>	9	11		dB	Vc= = 10 V, lc = 20 mA, f = 1.0 GHz
Noise Figure	NF		1.5	3.0	dB	Vce = 10 V, lc = 5 mA, f = 1.0 GHz
Maximum Available Gain	MAG		14		dB	VcE = 10 V, Ic = 20 mA, f = 1.0 GHz

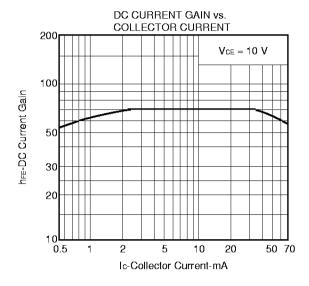
### hre Classification

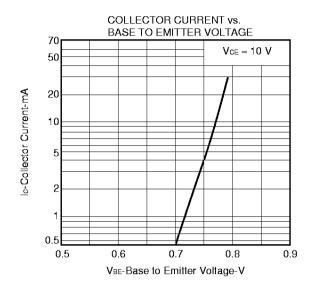
Class	E/P *	F/Q *	
Marking	R2	R3	
h⊧∈	40 to 120	100 to 200	

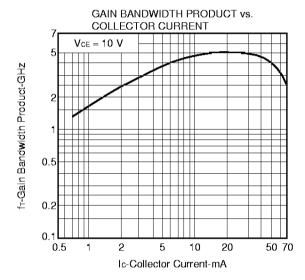
<sup>\*</sup> Old Specification / New Specification

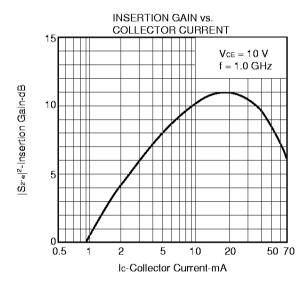


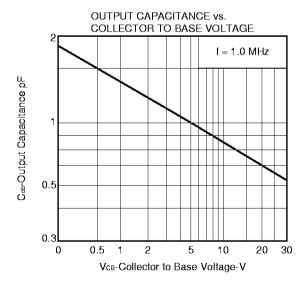
# TYPICAL CHARACTERISTICS (Ta = 25 °C)

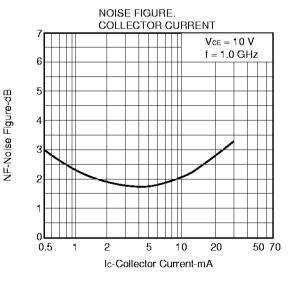


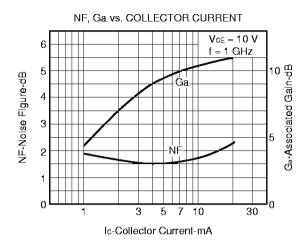












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Anti-radioactive design is not implemented in this product.

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